

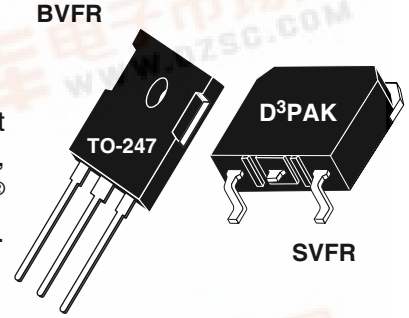


600V 16A 0.40Ω  
 APT6040BVFR APT6040SVFR  
 APT6040BVFRG\*APT6040SVFRG\*

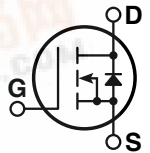
\*G Denotes RoHS Compliant, Pb Free Terminal Finish.

## POWER MOS V<sup>®</sup> FREDFET

Power MOS V<sup>®</sup> is a new generation of high voltage N-Channel enhancement mode power MOSFETs. This new technology minimizes the JFET effect, increases packing density and reduces the on-resistance. Power MOS V<sup>®</sup> also achieves faster switching speeds through optimized gate layout.



- Faster Switching
- Lower Leakage
- TO-247 or Surface Mount D<sup>3</sup>PAK Package
- Avalanche Energy Rated
- **FAST RECOVERY BODY DIODE**



### MAXIMUM RATINGS

All Ratings: T<sub>C</sub> = 25°C unless otherwise specified.

Symbol	Parameter	APT6040B_SVFR(G)	UNIT
V <sub>DSS</sub>	Drain-Source Voltage	600	Volts
I <sub>D</sub>	Continuous Drain Current @ T <sub>C</sub> = 25°C	16	Amps
I <sub>DM</sub>	Pulsed Drain Current <sup>①</sup>	64	
V <sub>GS</sub>	Gate-Source Voltage Continuous	±30	Volts
V <sub>GSM</sub>	Gate-Source Voltage Transient	±40	
P <sub>D</sub>	Total Power Dissipation @ T <sub>C</sub> = 25°C	250	Watts
	Linear Derating Factor	2.0	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range	-55 to 150	°C
T <sub>L</sub>	Lead Temperature: 0.063" from Case for 10 Sec.	300	
I <sub>AR</sub>	Avalanche Current <sup>①</sup> (Repetitive and Non-Repetitive)	16	Amps
E <sub>AR</sub>	Repetitive Avalanche Energy <sup>①</sup>	30	mJ
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>④</sup>	960	

### STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage (V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA)	600			Volts
R <sub>DS(on)</sub>	Drain-Source On-State Resistance <sup>②</sup> (V <sub>GS</sub> = 10V, I <sub>D</sub> = 8A)			0.400	Ohms
I <sub>DSS</sub>	Zero Gate Voltage Drain Current (V <sub>DS</sub> = 600V, V <sub>GS</sub> = 0V)			250	μA
	Zero Gate Voltage Drain Current (V <sub>DS</sub> = 480V, V <sub>GS</sub> = 0V, T <sub>C</sub> = 125°C)			1000	
I <sub>GSS</sub>	Gate-Source Leakage Current (V <sub>GS</sub> = ±30V, V <sub>DS</sub> = 0V)			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage (V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 1mA)	2		4	Volts

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

**DYNAMIC CHARACTERISTICS**

**APT6040B\_SVFR(G)**

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 25V$ $f = 1\text{ MHz}$		2600	3120	pF
$C_{oss}$	Output Capacitance			305	425	
$C_{rss}$	Reverse Transfer Capacitance			125	180	
$Q_g$	Total Gate Charge ③	$V_{GS} = 10V$ $V_{DD} = 300V$ $I_D = 16A @ 25^\circ C$		115	170	nC
$Q_{gs}$	Gate-Source Charge			15	25	
$Q_{gd}$	Gate-Drain ("Miller") Charge			52	75	
$t_{d(on)}$	Turn-on Delay Time	$V_{GS} = 15V$ $V_{DD} = 300V$ $I_D = 16A @ 25^\circ C$ $R_G = 1.6\Omega$		10	20	ns
$t_r$	Rise Time			9	18	
$t_{d(off)}$	Turn-off Delay Time			38	50	
$t_f$	Fall Time			6	12	

**SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS**

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
$I_S$	Continuous Source Current (Body Diode)			16	Amps
$I_{SM}$	Pulsed Source Current ① (Body Diode)			64	
$V_{SD}$	Diode Forward Voltage ② ( $V_{GS} = 0V, I_S = -16A$ )			1.3	Volts
$dv/dt$	Peak Diode Recovery $dv/dt$ ⑤			15	V/ns
$t_{rr}$	Reverse Recovery Time ( $I_S = -16A, di/dt = 100A/\mu s$ )	$T_j = 25^\circ C$		250	ns
		$T_j = 125^\circ C$		500	
$Q_{rr}$	Reverse Recovery Charge ( $I_S = -16A, di/dt = 100A/\mu s$ )	$T_j = 25^\circ C$	1.9		$\mu C$
		$T_j = 125^\circ C$	6		
$I_{RRM}$	Peak Recovery Current ( $I_S = -16A, di/dt = 100A/\mu s$ )	$T_j = 25^\circ C$	15		Amps
		$T_j = 125^\circ C$	26		

**THERMAL CHARACTERISTICS**

Symbol	Characteristic	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction to Case			0.50	$^\circ C/W$
$R_{\theta JA}$	Junction to Ambient			40	

① Repetitive Rating: Pulse width limited by maximum junction temperature

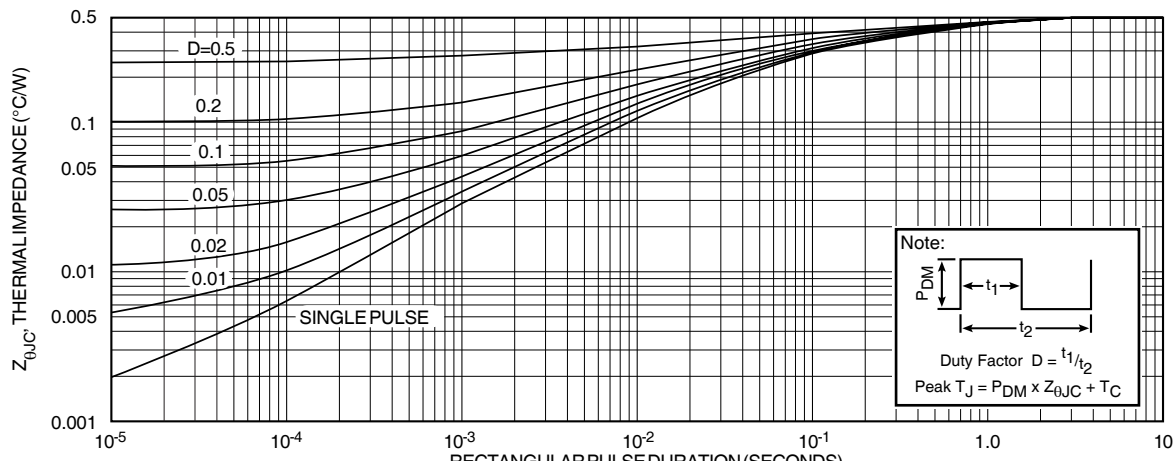
② Pulse Test: Pulse width < 380  $\mu s$ , Duty Cycle < 2%

③ See MIL-STD-750 Method 3471

④ Starting  $T_j = +25^\circ C$ ,  $L = 7.50mH$ ,  $R_G = 25\Omega$ , Peak  $I_L = 16A$

⑤  $dv/dt$  numbers reflect the limitations of the test circuit rather than the device itself.  $I_S \leq -I_D 16A$   $di/dt \leq 700A/\mu s$   $V_R \leq 600V$   $T_j \leq 150^\circ C$

APT Reserves the right to change, without notice, the specifications and information contained herein.



Typical Performance Curves

APT6040B\_SVFR(G)

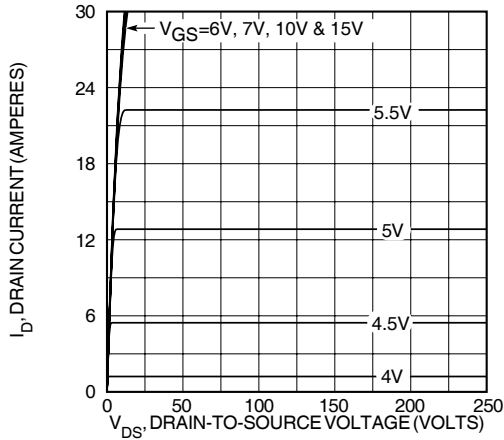


FIGURE 2, TYPICAL OUTPUT CHARACTERISTICS

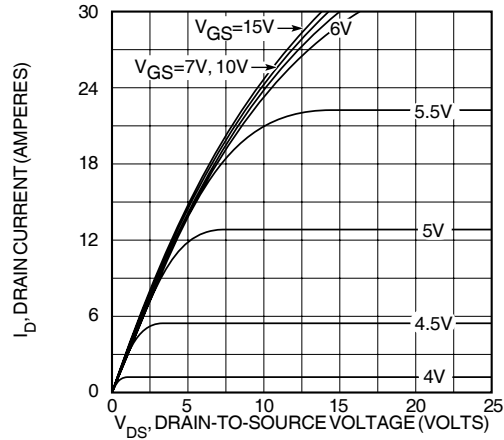


FIGURE 3, TYPICAL OUTPUT CHARACTERISTICS

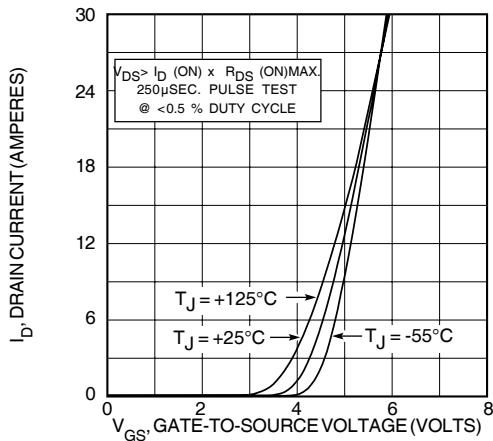


FIGURE 4, TYPICAL TRANSFER CHARACTERISTICS

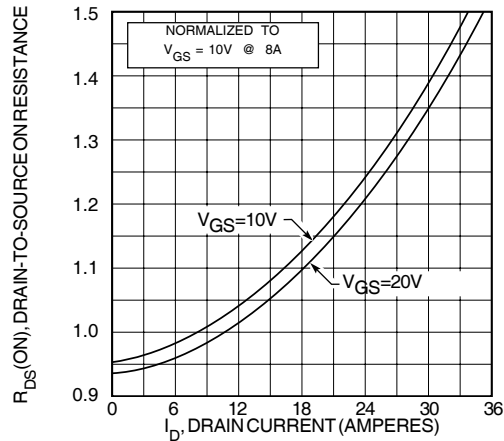


FIGURE 5,  $R_{DS(ON)}$  vs DRAIN CURRENT

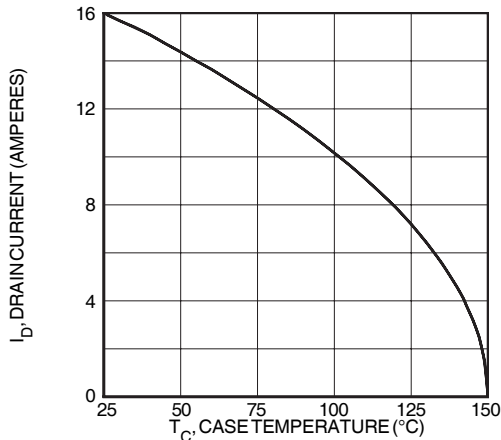


FIGURE 6, MAXIMUM DRAIN CURRENT vs CASE TEMPERATURE

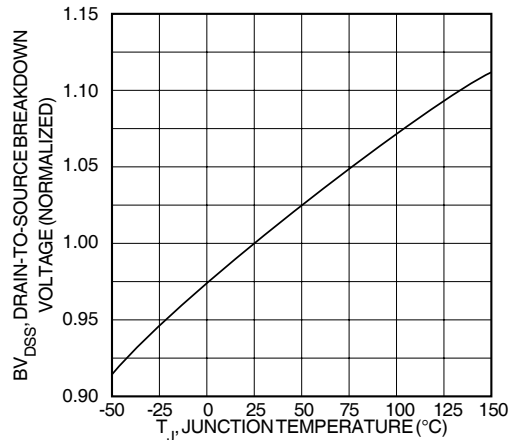


FIGURE 7, BREAKDOWN VOLTAGE vs TEMPERATURE

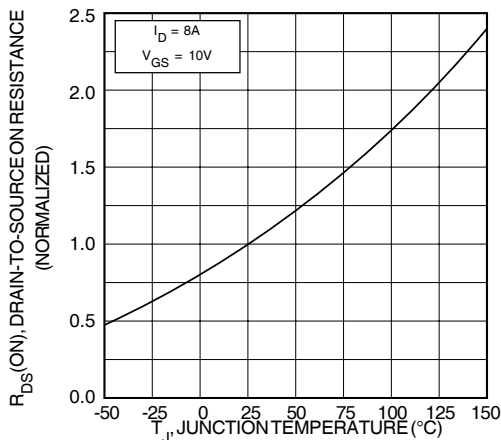


FIGURE 8, ON-RESISTANCE vs. TEMPERATURE

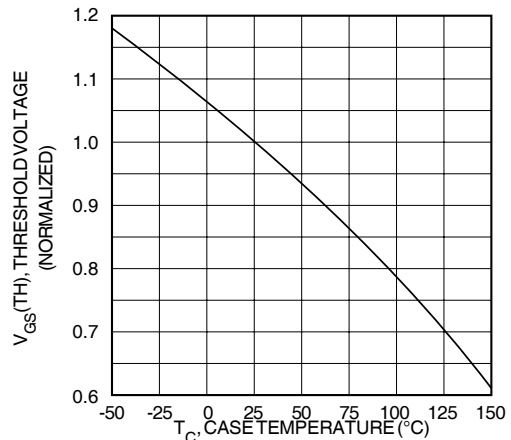


FIGURE 9, THRESHOLD VOLTAGE vs TEMPERATURE

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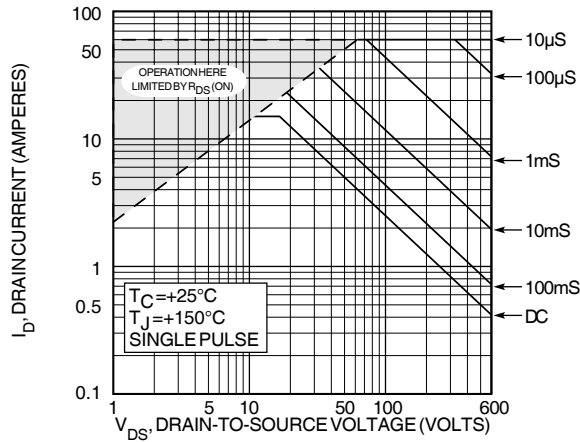


FIGURE 10, MAXIMUM SAFE OPERATING AREA

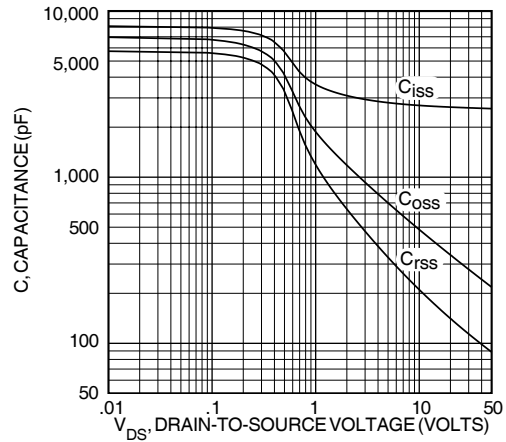


FIGURE 11, TYPICAL CAPACITANCE vs DRAIN-TO-SOURCE VOLTAGE

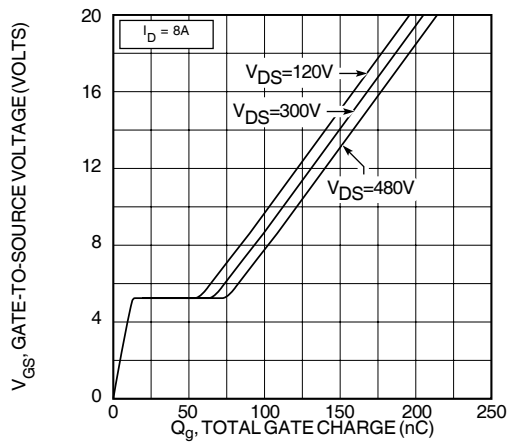


FIGURE 12, GATE CHARGES vs GATE-TO-SOURCE VOLTAGE

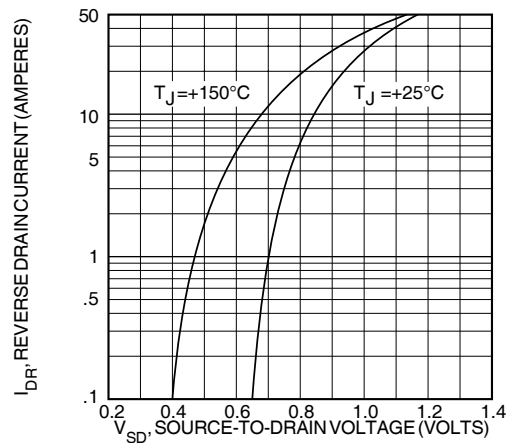
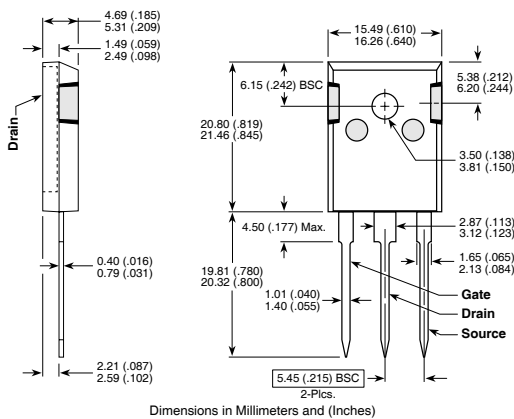


FIGURE 13, TYPICAL SOURCE-DRAIN DIODE FORWARD VOLTAGE

## TO-247 (BVFR) Package Outline

ⓔ1 SAC: Tin, Silver, Copper



## D<sup>3</sup>PAK (SVFR) Package Outline

ⓔ3 100% Sn

